Search Notes



Application/Control No.	Applicant(s)/Patent under Reexamination	
10/612,765	QIAN ET AL.	
Examiner	Art Unit	
John L. Goodrow	1756	

	SEARCHED				
Class	Subclass	Date	Examiner		
430	114	8/8/2005	JG		
	117				
	137.22				
		.,,			
		·			

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
L		L		

SEARCH N (INCLUDING SEAR	NOTES CH STRATEGY	')
	DATE	EXMR
inventor name search	8/8/2005	JG